## Notice of References Cited Application/Control No. 10/681,088 Applicant(s)/Patent Under Reexamination SOMEYA ET AL. Examiner Julie Anne Watko Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,608,736 B1	08-2003	Klaassen et al.	360/246
	В	US-			
	С	US-			
	D	US-			
	E	US-			*
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	Chen et al, Sept. 1994, IEEE Trans. Mag. v. 30 no. 5 pp. 2818-2820.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.